

**Notice of References Cited**

Application/Control No.

10/593,340

Applicant(s)/Patent Under  
Reexamination  
INOUE ET AL.

Examiner

Chris H. Chu

CE  
12/26/07

Art Unit

2874

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,892,015 B2	05-2005	Tadakuma et al.	385/122
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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